





Phase-shifting and vertical scanning interference microscopes can rapidly measures surface roughness from 0.1 nm to 2 mm steps. Both 2-D and 3-D measurements are available with up to 1024 x 1024 data point arrays.

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Several Fizeau interferometers for general optical testing are available. Beam diameters from less than 1 cm in diameter to larger than 60 cm diameter are available. Microsoft Windows based computer systems generally used.

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